# **NVMFS5834NL**

# Product Preview

### **Power MOSFET**

# 40 V, 9.3 m $\Omega$ , 76 A, Single N-Channel

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified
- These are Pb-Free Devices

### MAXIMUM RATINGS (T<sub>.I</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Cur-		T <sub>mb</sub> = 25°C	I <sub>D</sub>	76	Α
rent $R_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady	T <sub>mb</sub> = 100°C		54	
Power Dissipation	State	T <sub>mb</sub> = 25°C	$P_{D}$	107	W
R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)		T <sub>mb</sub> = 100°C		53	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	14	Α
rent R <sub>θJA</sub> (Notes 1, 3, 4)	Steady State	T <sub>A</sub> = 100°C		10	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.7	W
R <sub>θJA</sub> (Notes 1 & 3)		T <sub>A</sub> = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	264	Α
Current Limited by Package T <sub>A</sub> = 25°C (Note 4)			I <sub>DmaxPkg</sub>	80	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Diode)			I <sub>S</sub>	TBD	Α
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 50 V, V <sub>GS</sub> = 10 V, $I_{L(pk)}$ = 42 A, L = 0.1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	75	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\PsiJ-mb}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	41	

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

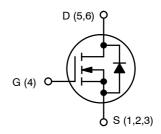
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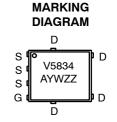
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	9.3 mΩ @ 10 V	76 A
	13.6 mΩ @ 4.5 V	76 A



**N-CHANNEL MOSFET** 





= Assembly Location Α

= Year W = Work Week ZZ = Lot Traceability

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NVMFS5834NLT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NVMFS5834NLT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### NVMFS5834NL

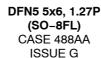
## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

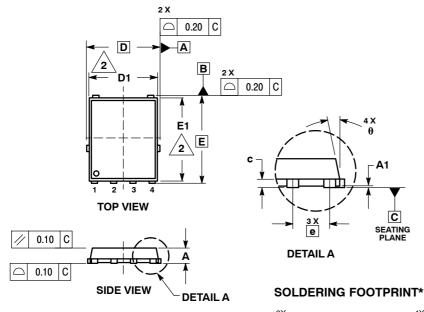
Parameter	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS			•			•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	40			V
Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25°C			1.0	μΑ	
		$V_{DS} = 40 \text{ V}$	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 5)					•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		1.0		3.0	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 38 A			7.4	9.3	mΩ
	V <sub>GS</sub> = 4.5 V, I <sub>D</sub>		I <sub>D</sub> = 38 A		10.9	13.6	1
CHARGES AND CAPACITANCES						•	•
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			1360		pF
Output Capacitance	C <sub>oss</sub>				209		1
Reverse Transfer Capacitance	C <sub>rss</sub>				161		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>DS</sub> = 48 V, I <sub>D</sub> = 38 A	V <sub>GS</sub> = 4.5 V		TBD		nC
			V <sub>GS</sub> = 10 V		27		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 V$ ,	T <sub>J</sub> = 25°C		0.85	1.2	V
		I <sub>S</sub> = 38 A	T <sub>J</sub> = 125°C		0.72		

<sup>5.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

#### NVMFS5834NL

#### PACKAGE DIMENSIONS





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.15 BSC			
D1	4.50	4.90	5.10	
D2	3.50		4.22	
E	6.15 BSC			
E1	5.50	5.80	6.10	
E2	3.45		4.30	
е	1.27 BSC			
G	0.51	0.61	0.71	
K	1.20	1.35	1.50	
L	0.51	0.61	0.71	
L1	0.05	0.17	0.20	
M	3.00	3.40	3.80	
θ	0 °		12 °	

- STYLE 1: PIN 1. SOURCE
  - 2. SOURCE
  - 3. SOURCE GATE
  - DRAIN
- зх <−0.750 1.270 8x b 0.10 C Α В .000 Ф e/2 0.05 C 0.965 Κ 1.330 0.905 2X F2 0.495 -PIN 5 (EXPOSED PAD) М 4.530 3.200 0.475 D2 G 2X **BOTTOM VIEW** → 1.530 4.560

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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